

MINISTRY OF SUPPLY - DLRD/RRE

VALVE ELECTRONIC
SEMICONDUCTOR DEVICE

CV448

Specification MCS/CV448	<u>SECURITY</u>	
Issue 5 dated 17th August 1959	<u>Specification</u>	<u>Valve</u>
To be used in conjunction with K1007 ←	Unclassified	Unclassified

← indicates a change

TYPE OF DEVICE - Germanium rectifier Diode				<u>MARKING</u> See K1007/4 CV Number Polarity markings Manufacturer's Code	
CONSTRUCTION - Glass Body, wire end leads					
PROTOTYPE - VX3069, VX4066					
<u>RATINGS AND CHARACTERISTICS</u> All limiting values are absolute					
				Note	
Max. Peak Inverse Voltage	(V)	100	A	<u>DIMENSIONS</u> See drawing on page 2	
Max. DC Reverse Voltage	(V)	75	A		
Max. DC Forward Current	(mA)	25	A		
Max. Slope Resistance at + 1V	(ohms)	900			
Min. Slope Resistance at -10V	(M)	0.5		<u>MOUNTING POSITION</u> Any	
Max. Storage Temperature	(°C)	100			
Min. Storage Temperature	(°C)	-40			
Max. Operating Frequency	(Mcs)	10	B		
Max. Continuous Vibration	(g)	10		<u>PACKAGING</u> See K1007, Section 14. The date code shall appear on multiple packs of 100 or more.	
Max. Shock	(g)	500			
<u>CAPACITANCES (pF)</u>					
C ak (max)		1.0			
C ac (max)		2.5			
C kc (max)		2.5			

NOTES

- A. The ratings apply for an ambient of 25°C, see derating curve on page 2 for ratings at other temperature.
- B. This rating is not an absolute value. No damage will be caused if the diode is operated at frequencies in excess of 10 Mcs but the efficiency may fall seriously above 10 Mcs.

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FIG. 1. DERATING CURVES

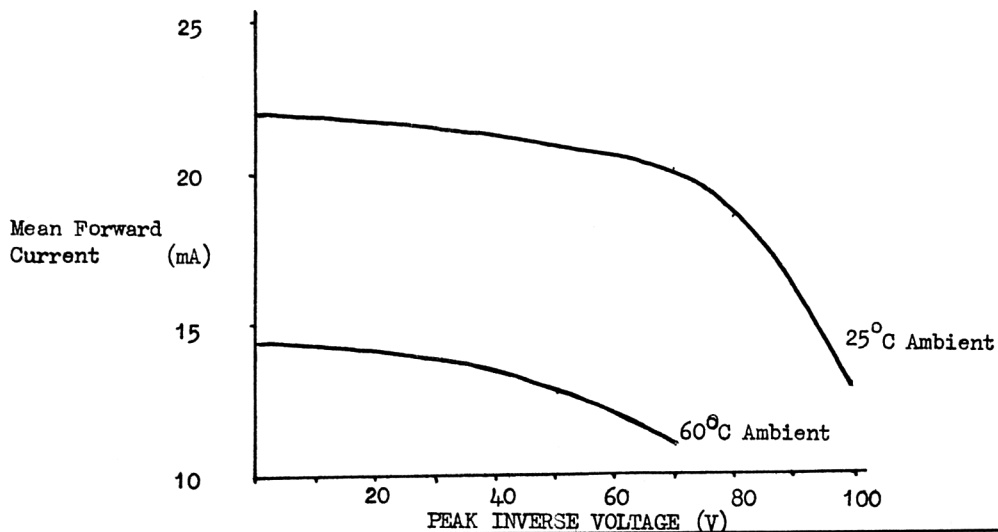
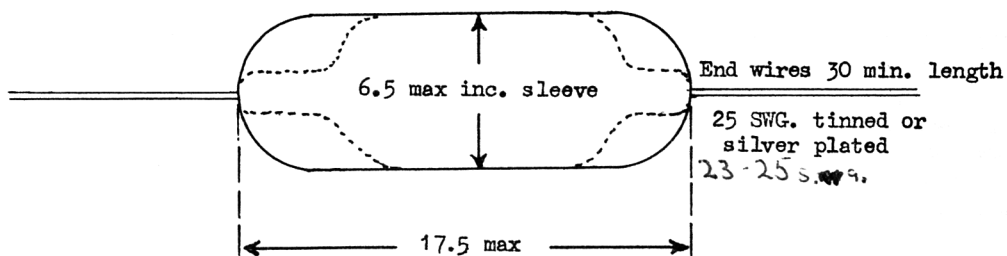


FIG. 2. DIMENSIONAL OUTLINE DRAWING
(Max. Space)



All dimensions in millimetres

To be performed in addition to those applicable in K1007 Sections 5.2 and 5.3

K1007	TEST	TEST CONDITIONS	AQL %	INSP. LEVEL	SYM- BOL	LIMITS		UNITS
						Min.	Max	
	<u>GROUP A</u>							
5B.4	Forward Voltage	If = 3mA dc		100%	Vf	-	1.0	V
5B.2	Reverse Current (1)	Vr = 50V		100%	Ir	-	100	μ A
	<u>GROUP B</u>							
	Peak Inverse Voltage	Approved CRT Display	0.65	II	V _{piv}	100	-	V
	or alternatively Peak Reverse Current	V _{rp} k = 100V	0.65	II	I _{rp} k	-	500	μ A
	Reverse Voltage	I _r = 200 μ A	0.65	II	V _r	75	-	V
	<u>GROUP C omitted</u>							
	<u>GROUP D</u>							
5B.2	Reverse Current (2)	Vr = 10V Tamb = 60°C min	2.5	IA	Ir	-	50	μ A
5B.5.1	Capacitance	F = 45 Mcs $\pm$ 5 Mcs V input = 10 mV rms max.		TA	C ak C ac C kc	- - -	1.0 2.5 2.5	pF pF pF
	<u>GROUP E</u>							
11.5	Soldering			IC				
10.1	Lead Fragility			IC				
10.2	Temperature cycling	Three cycles, -40°C to + 100°C		IC				
10.3	Climatic			IC				
11.3	Fatigue			IC				
11.4	Shock	Hammer angle = 30°		T.A				
	<u>Post Temperature- cycling, Climatic Fatigue and Shock Tests</u>	Combined AQL for each group of tests.	10.0					
8	Inoperatives		6.5					
5B.4	Forward Voltage	If = 3mA dc	6.5		Vf	-	1.1	V
5B.2	Reverse Current (1)	Vr = 50V	6.5		Ir	-	110	μ A

K1007 ref.	TEST	TEST CONDITIONS	AQL	INSP. LEVEL	SYM- BOL	LIMITS		UNITS
						Min.	Max.	
	<u>GROUP F</u>							
13.3.	LIFE	Halfwave circuit with resisttve load P. I. V. = 80V min. f = 50 c/s min. I _o = 10 mA min. T _{amb} = 45°C min.		Ia				
	<u>Life Test end point 1,000 hours</u>	Combined AQL	10					
5B.4	Forward Voltage	I _f = 3 mA do	6.5		V _f	-	1.1	V
5B.2	Reverse Current(1)	V _r = 50V	6.5		I _r	-	110	μA
13.4	Storage Life(1)	T _{amb} = -40°C t = 150 hrs		I				
13.5	Storage Life(2)	T _{amb} = 100°C t = 150 hrs		I				
	<u>Post storage life tests</u>	Combined AQL for each group of tests	6.5					
5B.4	Forward Voltage	I _f = 3 mA do	4.0		V _f	-	1.1	V
5B.2	Reverse Current(1)	V _r = 50V	4.0		I _r	-	110	μA
	<u>GROUP G</u>							
	Re-test after 28 days holding period			100%				
8	Inoperatives		0.5					
5B.4	Forward Voltage	I _f = 3 mA do	1.0		V _f	-	1.0	V

ELECTRONIC VALVE SPECIFICATIONS

SPECIFICATION MOS/CV448

ISSUE 5 dated 17th August, 1959

AMENDMENT NO.1

Page 2

Fig.2 Dimensional Outline Drawing

Amend legend "25 SWG. tinned or silver plated"
to read "23-25 SWG tinned or silver plated"

R.R.E.

February, 1960

N.16634D

CV448

N O T E

Specification CV448 is now filed in Book 'S'.

Remove Issue 4 from its numerical position in EVS and destroy. File this sheet in its place as a reminder to refer to Book 'S'.

October, 1959.